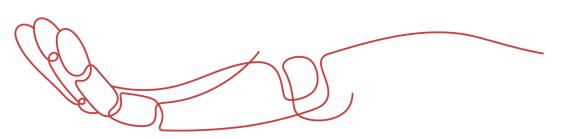




# **PRODUCT DATA SHEET**



To learn more about JGSEMI, please visit our website at







Datasheet

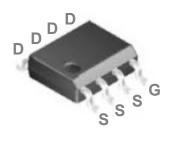
urces Samples

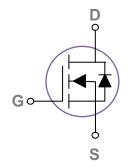
Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



## **General Description**

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.





BVDSS	RDSON	ID
30V	7.5m $\Omega$	15A

### **Features**

- 30V, 15A, RDS(ON)=10mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

## **Applications**

- Notebook
- Load Switch
- LED applications
- Hand-Held Device

## **Absolute Maximum Ratings** Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	30	V
$V_{GS}$	Gate-Source Voltage	±20	V
ı	Drain Current – Continuous (T <sub>C</sub> =25°C)	15	Α
I <sub>D</sub>	Drain Current – Continuous (T <sub>C</sub> =100°C)	9.5	Α
I <sub>DM</sub>	Drain Current – Pulsed <sup>1</sup>	60	Α
D	Power Dissipation (T <sub>C</sub> =25°C)	4	W
P <sub>D</sub>	Power Dissipation – Derate above 25°C	0.032	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
$T_J$	Operating Junction Temperature Range	-55 to 150	°C

## **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		85	°C/W
$R_{ heta JC}$	Thermal Resistance Junction to Case		31	°C/W



## **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

## **Off Characteristics**

Symbol	Symbol Parameter Conditions		Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	30			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.04		V/°C
I <sub>DSS</sub>	Drain Source Leekage Current	$V_{DS}$ =30V , $V_{GS}$ =0V , $T_J$ =25 $^{\circ}$ C			1	uA
	Drain-Source Leakage Current	V <sub>DS</sub> =24V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>GS</sub> =±20V , V <sub>DS</sub> =0V			±100	nA

### **On Characteristics**

D	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =6A		7.5	10	mΩ
R <sub>DS(ON)</sub>	Static Dialii-Source On-Resistance	$V_{GS}$ =4.5 $V$ , $I_D$ =3 $A$		10.5	14	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	\/ -\/   -250uA	1.2	1.6	2.5	٧
$ riangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250uA$		-4		mV/°C
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =10A		18		S

# **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2, 3</sup>		 7.5	15	
$Q_gs$	Gate-Source Charge <sup>2, 3</sup>	$V_{DS}$ =15V , $V_{GS}$ =4.5V , $I_{D}$ =10A	 1.3	3	nC
$Q_gd$	Gate-Drain Charge <sup>2, 3</sup>		 4.5	9	
$T_{d(on)}$	Turn-On Delay Time <sup>2, 3</sup>		 4.8	9	
Tr	Rise Time <sup>2, 3</sup>	$V_{DD}$ =15V , $V_{GS}$ =10V , $R_{G}$ =3.3 $\Omega$	 12.5	25	no
$T_{d(off)}$	Turn-Off Delay Time <sup>2, 3</sup>	I <sub>D</sub> =15A	 27.6	50	ns
$T_f$	Fall Time <sup>2, 3</sup>		 8.2	16	
C <sub>iss</sub>	Input Capacitance		 750	1350	
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =25V , $V_{GS}$ =0V , F=1MHz	 150	300	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		 110	200	
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	 2.7	4.5	Ω

# **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	\/ -\/ -0\/ Force Current			15	Α
I <sub>SM</sub>	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			30	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			1	V

#### Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 3. Essentially independent of operating temperature.



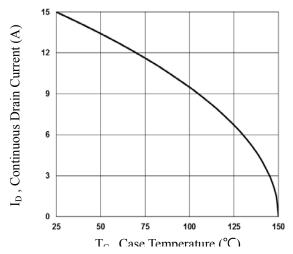


Fig.1 Continuous Drain Current vs. T<sub>c</sub>

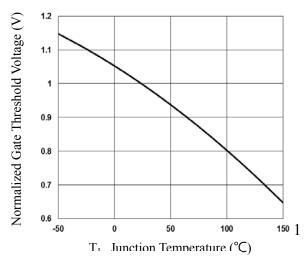


Fig.3 Normalized  $V_{th}$  vs.  $T_J$ 

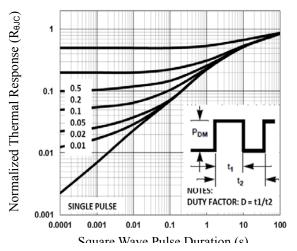


Fig.5 Normalized Transient Impedance

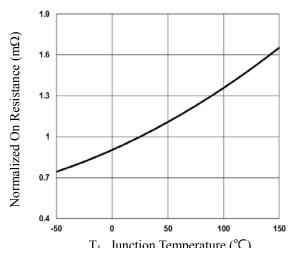


Fig.2 Normalized RDSON vs. T,

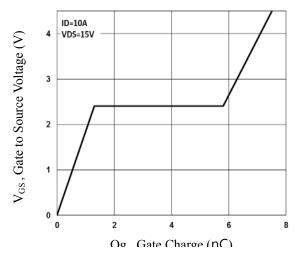


Fig.4 Gate Charge Waveform

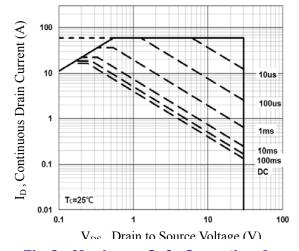
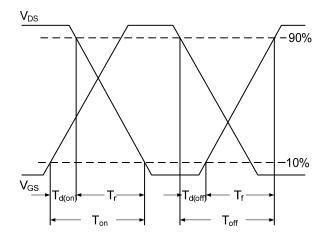


Fig.6 Maximum Safe Operation Area







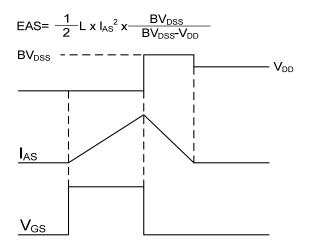
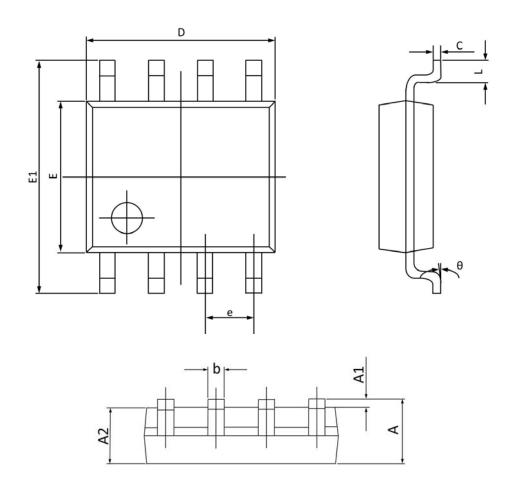


Fig.8 EAS Waveform



# **SOP8 PACKAGE INFORMATION**



Symbol	<b>Dimensions In</b>	Millimeters	Dimension	<b>Dimensions In Inches</b>	
Symbol	MAX	MIN	MAX	MIN	
A	1.750	1.350	0.069	0.053	
A1	0.250	0.100	0.010	0.004	
A2	1.500	1.300	0.059	0.051	
b	0.490	0.350	0.019	0.014	
C	0.260	0.190	0.010	0.007	
D	5.100	4.700	0.201	0.185	
E	4.100	3.700	0.161	0.146	
E1	6.200	5.800	0.244	0.228	
e	1.271	BSC	0.05BSC		
L	0.900	0.400	0.035	0.016	
θ	8°	0°	8°	<b>0</b> °	



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